Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination
10/696,771	GUHA ET AL.

10/696,77

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination
GUHA ET AL.
Art Unit

SEARCHED				
Class	Subclass	Date	Examiner	
216	17	4/23/2007	BT	
216	60	4/23/2007	ВТ	
438	715	4/23/2007	ВТ	
438	52	4/23/2007	ВТ	
438	56	4/23/2007	, BT	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	·DATE	EXMŖ	
Updated search using USPAT, USPG- PUB, JPO, EPO, DERWENT database	4/23/2007	ВТ	
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